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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/764,641	OSAKI, HIROYUKI	
Examiner	Art Unit	
David D. Davis	2627	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner	
See	attached	4/1/2007	DDD	
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